

N- and P-Channel 40 V (D-S) Power MOSFET

PRODUCT SUMMARY

	V _{DS} (V)	R _{DS(on)} (mΩ)(Typ.)	I _D (A) ^a	Q _g (Typ.)
N-Channel	40	6.9 at V _{GS} = 10 V	35	42
		13 at V _{GS} = 4.5 V		
P-Channel	- 40	12 at V _{GS} = - 10 V	- 40	30
		16 at V _{GS} = - 4.5 V		

FEATURES

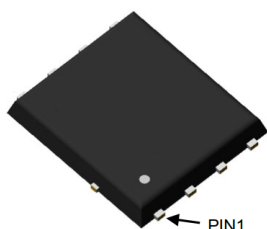
- DT-Trench Power MOSFET
- 100 % R_g and UIS tested
- Excellent package for heat dissipation
- Halogen Free


RoHS
 COMPLIANT

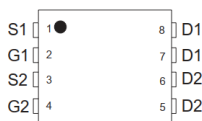
APPLICATIONS

- Load switching
- Motor drive

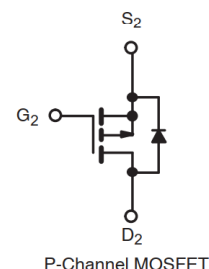
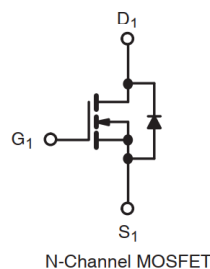
Top View



DFN5X6-8L Pin Configuration



Top View



ABSOLUTE MAXIMUM RATINGS (T_C = 25 °C, unless otherwise noted)

PARAMETER		SYMBOL	N-Channel	P-Channel	UNIT
Drain-Source Voltage		V _{DS}	40	- 40	V
Gate-Source Voltage		V _{GS}	± 20	± 20	
Continuous Drain Current (T _J = 150 °C) ^a	T _C = 25 °C	I _D	35	- 40	A
	T _C = 100 °C		23	- 27	
Pulsed Drain Current ^b		I _{DM}	140	- 160	
Maximum Power Dissipation ^c	T _C = 25 °C	P _{tot}	30	30	W
	T _C = 100 °C		12	12	
Single Avalanche Energy		E _{AS}	295	310	mJ
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +150		°C

THERMAL RESISTANCE RATINGS

Parameter		Symbol	Typ	Max	Unit
Maximum Junction-to-Ambient ^d	t ≤ 10 s	R _{thJA}	65	79	°C/W
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	3.5	4.2	

Notes

- Calculated continuous current based on maximum allowable junction temperature.
- Repetitive rating; pulse width limited by max. junction temperature.
- P_d is based on max. junction temperature, using junction-case thermal resistance.
- The value of R_{thJA} is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T_a=25 °C.

N-Channel Electrical Characteristics ($T_J = 25\text{ }^{\circ}\text{C}$, unless otherwise noted)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static						
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	40	-	-	V
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA	1	-	3	
Gate-Body Leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = ± 20 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 40 V, V _{GS} = 0 V	-	-	1	μA
		V _{DS} = 32 V, V _{GS} = 0 V, T _J = 125 °C	-	-	5	
On-State Drain Current ^a	I _{D(on)}	V _{DS} ≥ 5 V, V _{GS} = 5 V	35	-	-	A
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 10 V, I _D = 12 A	-	6.9	10.5	mΩ
		V _{GS} = 4.5 V, I _D = 10 A	-	13	16	
Forward Transconductance ^a	g _{fs}	V _{DS} = 10 V, I _D = 10 A	-	68	-	S
Dynamic ^b						
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 20 V, f = 1 MHz	-	2320	-	pF
Output Capacitance	C _{oss}		-	204	-	
Reverse Transfer Capacitance	C _{rss}		-	192	-	
Total Gate Charge ^c	Q _g	V _{DS} = 20 V, V _{GS} = 10 V, I _D = 12 A	-	42	-	nC
Gate-Source Charge ^c	Q _{gs}		-	4.5	-	
Gate-Drain Charge ^c	Q _{gd}		-	6.6	-	
Gate Resistance	R _g	f = 1 MHz	-	10	-	Ω
Turn-On Delay Time ^c	t _{d(on)}	V _{DS} = 20 V, I _D = 12 A, R _g = 2.5 Ω V _{GS} = 10 V	-	9	-	ns
Rise Time ^c	t _r		-	28	-	
Turn-Off Delay Time ^c	t _{d(off)}		-	29	-	
Fall Time ^c	t _f		-	40	-	
Drain-Source Body Diode Ratings and Characteristics ^b (T _C = 25 °C)						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C	-	-	35	A
Pulsed Current (t = 100 μs)	I _{SM}		-	-	140	A
Forward Voltage ^a	V _{SD}	I _F = 10 A, V _{GS} = 0 V	-	-	1.2	V
Reverse Recovery Time	t _{rr}	I _F = 10 A, di/dt = 100 A/μs	-	20	-	ns
Reverse Recovery Charge	Q _{rr}		-	6.3	-	nC

Notes

- a. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.
 b. Guaranteed by design, not subject to production testing.
 c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

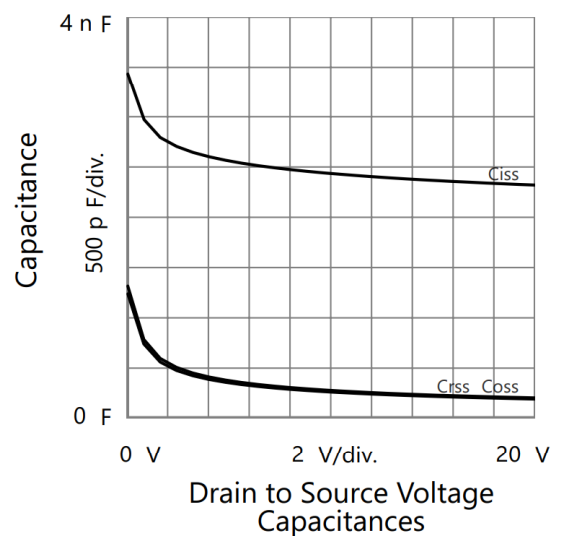
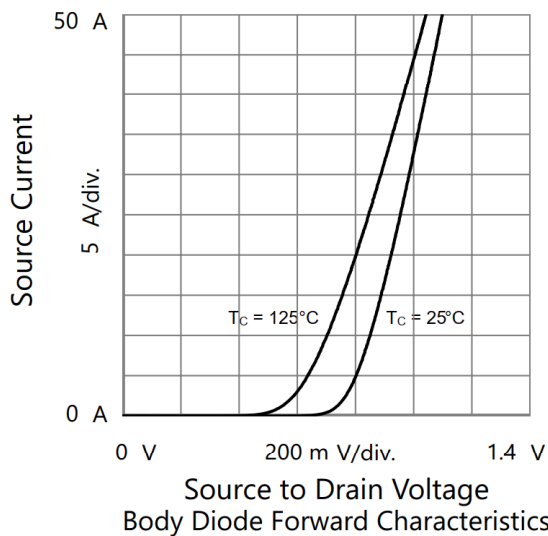
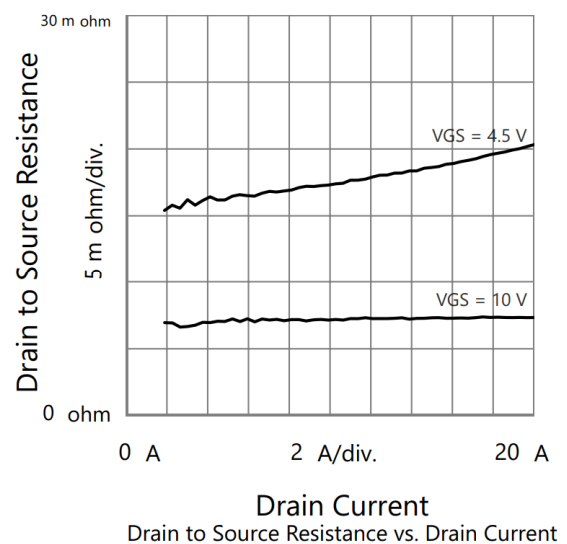
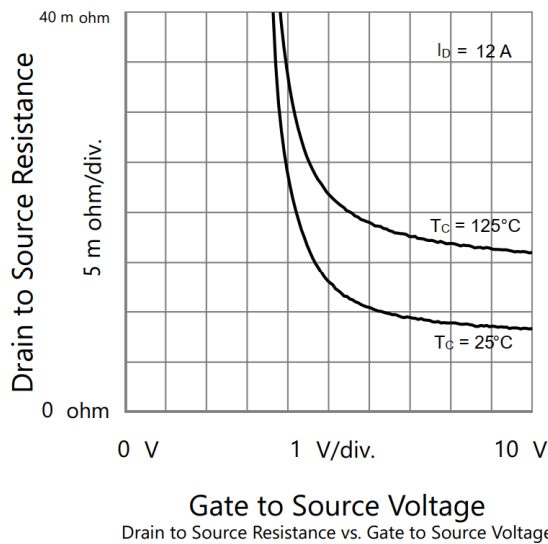
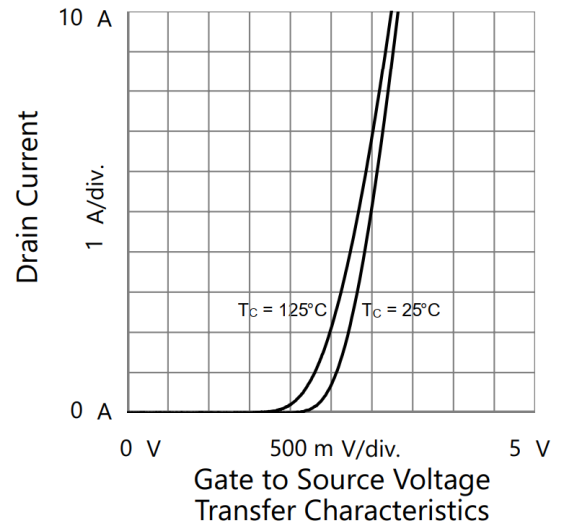
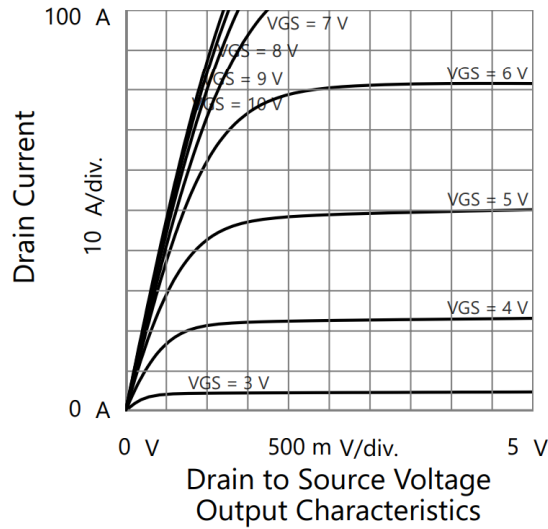
P-Channel Electrical Characteristics (T _J = 25 °C, unless otherwise noted)						
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static						
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = - 250 μA	- 40	-	-	V
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = - 250 μA	- 1	-	- 3	
Gate-Body Leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = ± 20 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 40 V, V _{GS} = 0 V	-	-	- 1	μA
		V _{DS} = - 32 V, V _{GS} = 0 V, T _J = 125 °C	-	-	- 5	
On-State Drain Current ^a	I _{D(on)}	V _{DS} ≤ -5 , V _{GS} = - 5 V	- 40	-	-	A
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 10 V, I _D = - 10 A	-	12	18	mΩ
		V _{GS} = - 4.5 V, I _D = - 8 A	-	16	23	
Forward Transconductance ^a	g _{fs}	V _{DS} = - 5 V, I _D = - 10 A	-	60	-	S
Dynamic ^b						
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = - 20 V, f = 1 MHz	-	3700	-	pF
Output Capacitance	C _{oss}		-	273	-	
Reverse Transfer Capacitance	C _{rss}		-	255	-	
Total Gate Charge ^c	Q _g	V _{DS} = - 20 V, V _{GS} = - 10 V, I _D = - 10 A	-	30	-	nC
Gate-Source Charge ^c	Q _{gs}		-	4	-	
Gate-Drain Charge ^c	Q _{gd}		-	1	-	
Gate Resistance	R _g	f = 1 MHz	-	6.5	-	Ω
Turn-On Delay Time ^c	t _{d(on)}	V _{DS} = - 20 V, I _D = - 10 A, R _g = 2.5 Ω V _{GS} = - 10 V	-	7.5	-	ns
Rise Time ^c	t _r		-	5	-	
Turn-Off Delay Time ^c	t _{d(off)}		-	105	-	
Fall Time ^c	t _f		-	70	-	
Drain-Source Body Diode Ratings and Characteristics ^b (T _C = 25 °C)						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C	-	-	- 40	A
Pulsed Current (t = 100 μs)	I _{SM}		-	-	- 160	A
Forward Voltage ^a	V _{SD}	I _F = - 10 A, V _{GS} = 0 V	-	-	- 1.2	V
Reverse Recovery Time	t _{rr}	I _F = - 10 A, di/dt = 100 A/μs	-	18	-	ns
Reverse Recovery Charge	Q _{rr}		-	7	-	nC

Notes

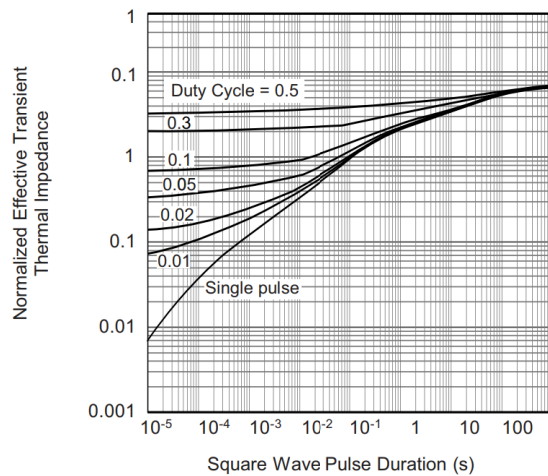
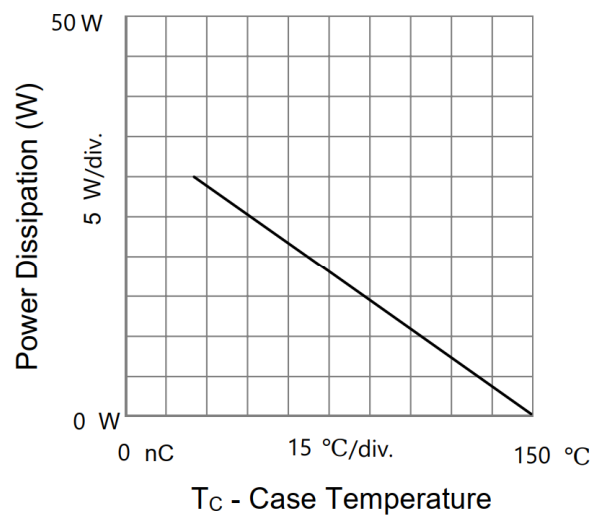
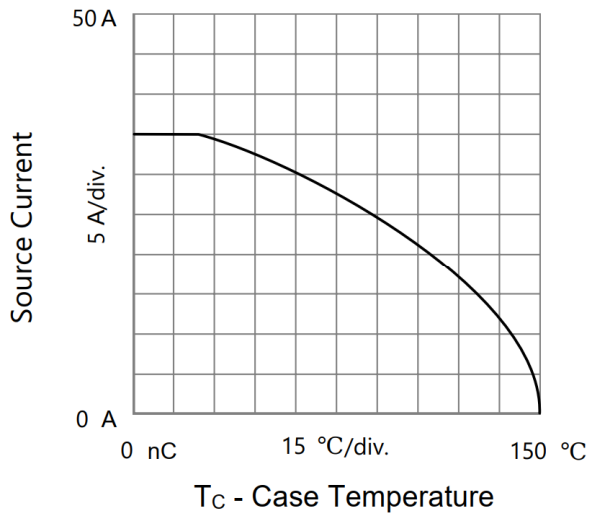
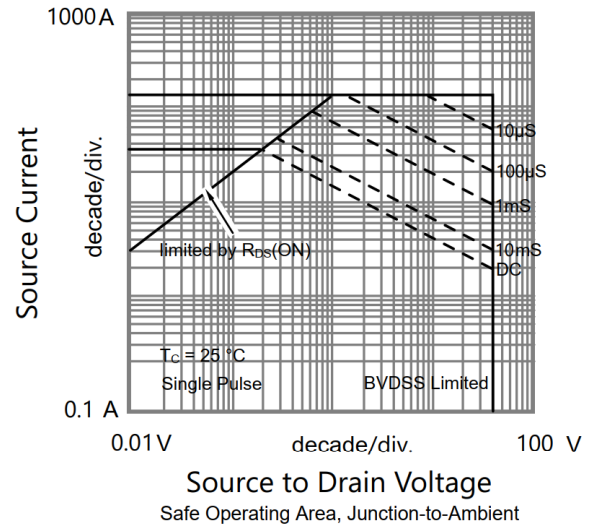
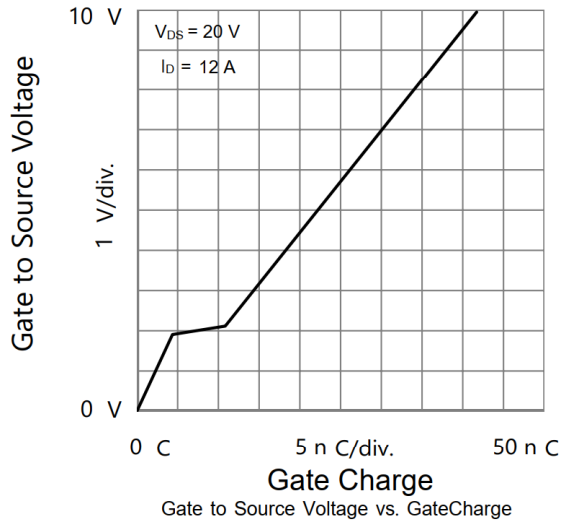
- a. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.
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N-CHANNEL TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

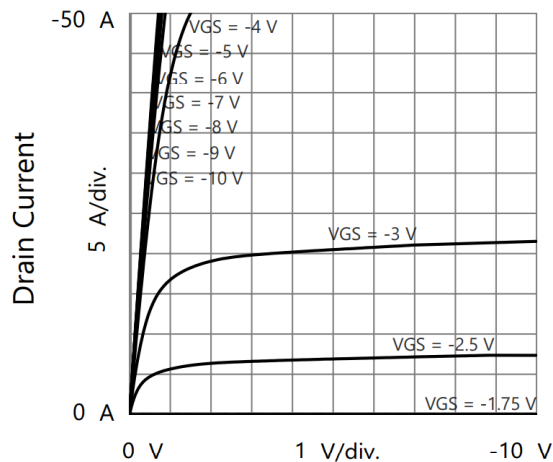


N-CHANNEL TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

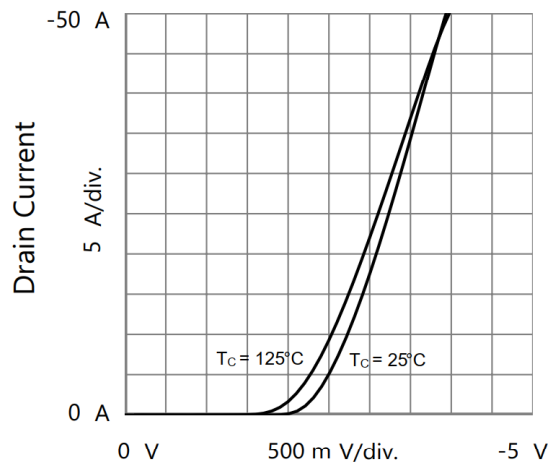


Normalized Thermal Transient Impedance

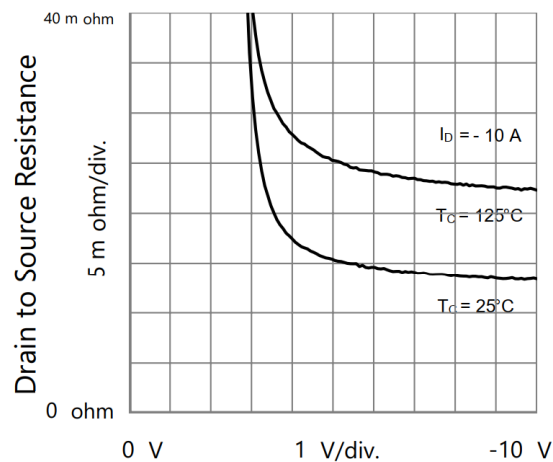
P-CHANNEL TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



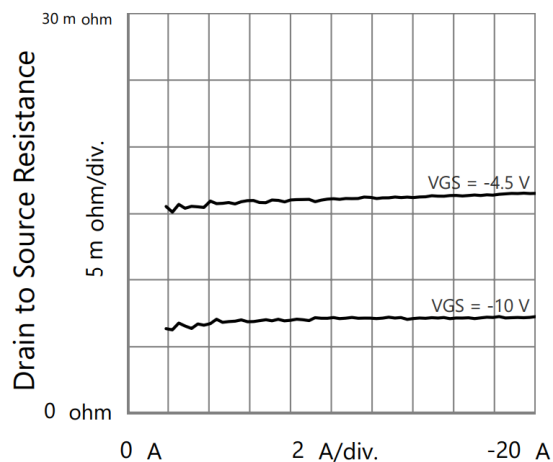
Drain to Source Voltage
Output Characteristics



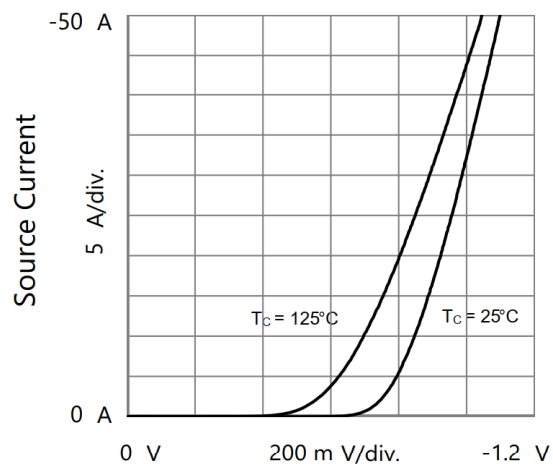
Gate to Source Voltage
Transfer Characteristics



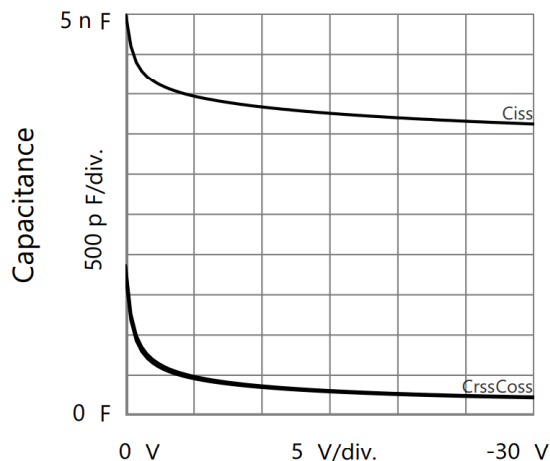
Gate to Source Voltage
Drain to Source Resistance vs. Gate to Source Voltage



Drain Current
Drain to Source Resistance vs. Drain Current

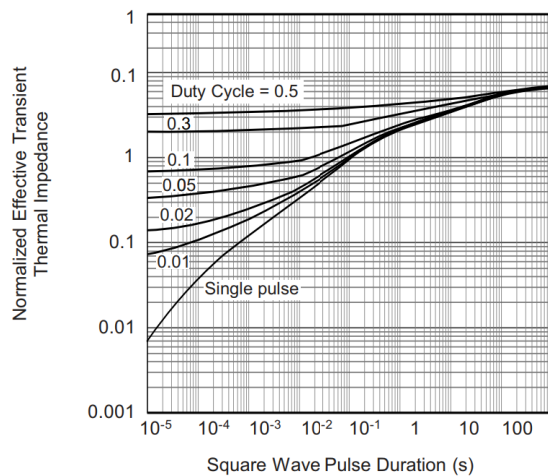
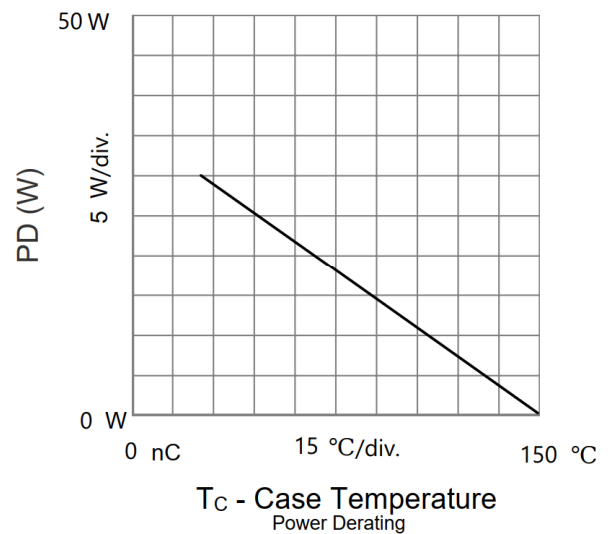
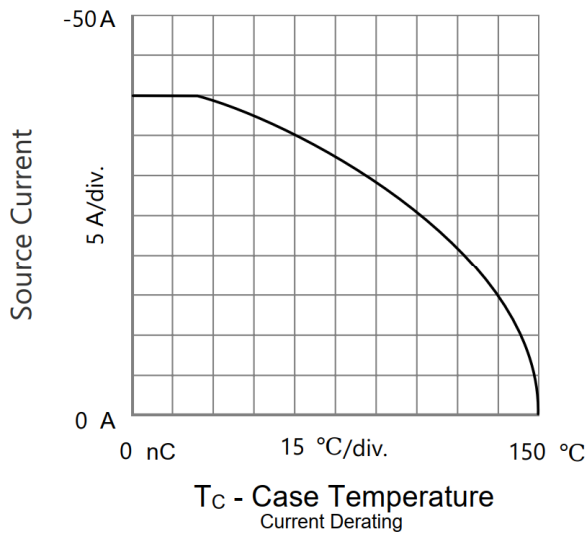
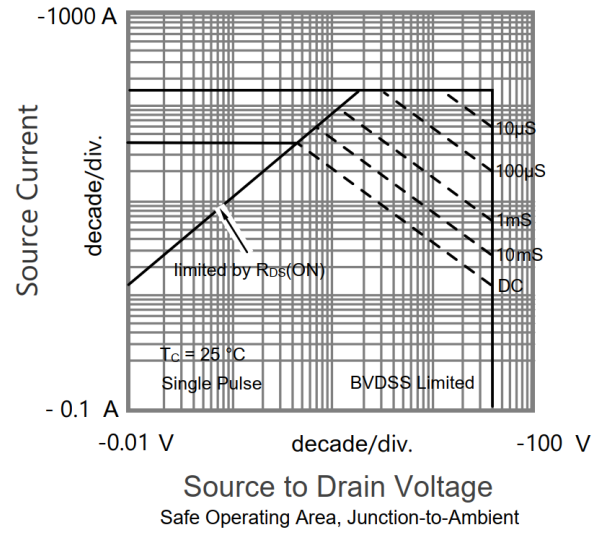
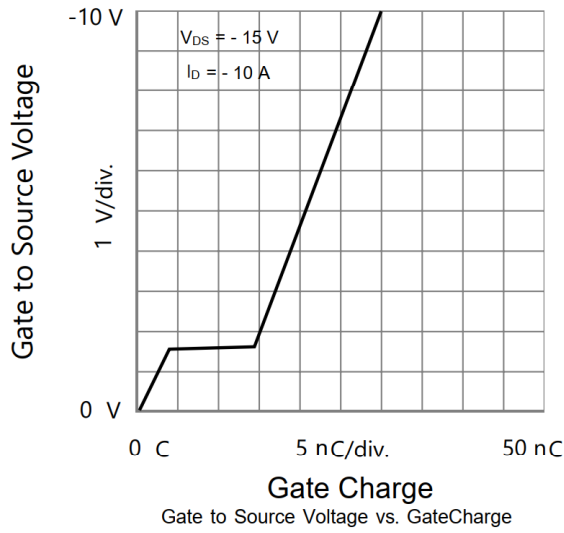


Source to Drain Voltage
Body Diode Forward Characteristics



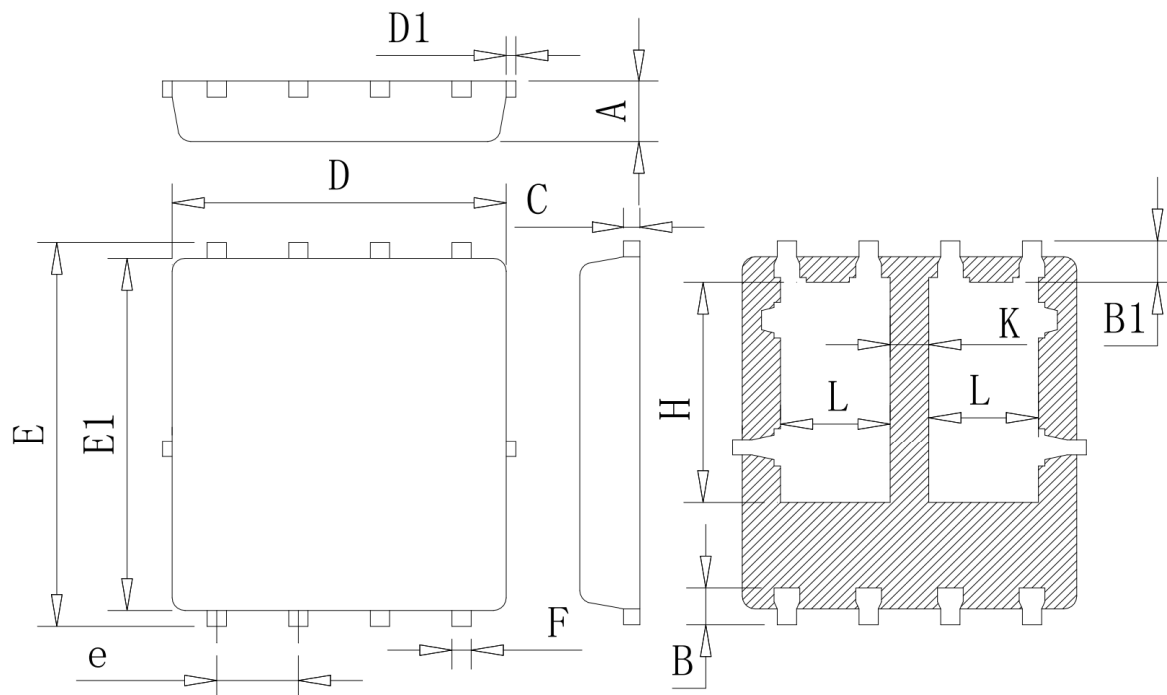
Drain to Source Voltage
Capacitances

P-CHANNEL TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance

DFN5X6-8L-D PACKAGE OUTLINE



COMMON DIMENSIONS
(UNITS OF MEASURE=MILLIMETER)

Symbol	Min	Typ	Max
A	0.85	0.95	1.05
B	0.46	0.58	0.73
B1	0.52	0.65	0.78
C	0.18	0.254	0.32
D	4.70	5.20	5.50
D1	-	-	0.18
E	5.75	6.05	6.35
E1	5.35	5.65	5.85
e	1.15	1.27	1.50
F	0.15	0.30	0.50
H	3.15	3.47	3.80
L	1.35	1.70	2.10
K	0.35	0.60	1.00

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